

Search Notes

Application/Control No.

10/656,616

Examiner

Benjamin Huh

Applicant(s)/Patent under
Reexamination

THEEUWES ET AL.

Art Unit

3767

SEARCHED

Class	Subclass	Date	Examiner
604	246-250, 167.01- 167.07	5/1/2006	BHH
604	256-258	5/1/2006	BHH
604	30-34	5/1/2006	BHH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	5/1/2006	BHH
Classification search consulted with Catherine Williams	5/1/2006	BHH